

SEMICONDUCTOR PACKAGING STRUCTURE

2 BACKGROUND OF THE INVENTION

3 1. Field of the Invention

4 The present invention relates to a semiconductor packaging structure, and
5 more particularly to an improved semiconductor packaging structure that is easy to
6 fabricate, incurs a low production cost and has a good heat dissipation.

7 2. Description of Related Art

With reference to Fig. 13 a conventional semiconductor packaging structure for sensing optical signals, such as a charge coupled device (CCD) or a photoelectric element, has a substrate (50) defined with a groove (51) in the middle portion of the substrate (50), wherein a chip (52) is mounted on the substrate (50). The substrate (50) further has multiple traces (not shown) arranged thereon, and the chip (52) is electrically connected to the multiple traces via multiple gold wires (53). Then a transparent cover (54) covers the groove (51) for protecting the chip (52).

16 In general, the substrate (50) used in foregoing semiconductor packaging
17 is formed of ceramic material. The advantage of the ceramic material is that the
18 ceramic material would not absorb the moisture in the air, so that the chip (52)
19 enclosed in the substrate (50) would not be affected by the moisture, and is able to
20 work stably. However, ceramic material is expensive and difficult to process.
21 Therefrom, another conventional semiconductor packaging structure is disclosed.

With reference to Fig. 14, the packaging structure is substantially the same as that shown in Fig. 13, wherein the packaging structure shown in Fig. 14 comprises a substrate (60) made of epoxy resin, such as BT₁, a wall portion (61)

1 installed on the periphery of the substrate to define a groove (62) for receiving a
2 chip (63) mounted on the substrate (60), and a plurality of leads (64) arranged on a
3 top surface of the substrate (60) and extending to pass through a lateral side of the
4 substrate (60) to a bottom surface of the substrate (60). The chip (60) is further
5 electrically connected to the plurality of leads (64) via multiple gold wires (65). A
6 transparent cover (66) covers the groove (62) to enclose the chip (63). Although
7 such a semiconductor packaging structure is easy to process and is able to reduce
8 the production cost, the packaging structure still has some shortcomings as listed
9 below.

10 1. Since the substrate is made of an epoxy resin, the substrate is easy to
11 absorb moisture, and the chip mounted on the substrate would be affected by the
12 moisture, so that the stability of the chip is reduced.

13 2. The plurality of leads on the substrate is formed by an electroplating
14 process, such that the reliability of forming the leads is hard to control.

15 3. The efficiency of heat dissipation of the epoxy resin substrate is much
16 lower than a substrate made of metal.

17 4. Since the plurality of leads on the substrate extends from the top surface
18 of the substrate and passes through a lateral side of the substrate to a bottom
19 surface of the substrate, thus the signal conducting path is very long, and the long
20 path may delay the signal conducting.

21 To overcome the shortcomings, the present invention tends to provide a
22 semiconductor packaging structure so as to mitigate and obviate the
23 aforementioned problems.

1 SUMMARY OF THE INVENTION

2 The primary objective of the invention is to provide a semiconductor
3 packaging structure that is easy to fabricate, is able to reduce the production cost,
4 has a high efficiency of heat dissipation and is able to mitigate a signal delay.

5 Other objects, advantages and novel features of the invention will become
6 more apparent from the following detailed description when taken in conjunction
7 with the accompanying drawings.

8 BRIEF DESCRIPTION OF THE DRAWINGS

9 Fig. 1 is a perspective view of a semiconductor packaging structure in
10 accordance with the present invention;

11 Fig. 2 is a cross-sectional view of a first embodiment of a semiconductor
12 packaging structure in accordance with the present invention;

13 Fig. 3 is a perspective view of the semiconductor packaging structure of
14 Fig. 1, wherein a transparent cover is not yet installed on the semiconductor
15 packaging structure;

16 Fig. 4 is a cross-sectional view of a second embodiment of a
17 semiconductor packaging structure in accordance with the present invention;

18 Fig. 5 is a cross-sectional view of a third embodiment of a semiconductor
19 packaging structure in accordance with the present invention;

20 Fig. 6 is a cross-sectional view of a fourth embodiment of a semiconductor
21 packaging structure in accordance with the present invention;

22 Fig. 7 is perspective view of a fifth embodiment of a semiconductor
23 packaging structure in accordance with the present invention;

24 Fig. 8 is a perspective view of the semiconductor packaging structure of

1 Fig. 7, wherein a transparent cover is not yet installed on the semiconductor
2 packaging structure;

3 Fig. 9 is a plan view of a top lead frame in accordance with the present
4 invention;

5 Fig. 10 is a plan view of a bottom lead frame in accordance with the
6 present invention;

7 Fig. 11 is a cross-sectional view of the fifth embodiment of the
8 semiconductor packaging structure of the present invention;

9 Fig. 12 is sequential view shows to isolate multiple semiconductor
10 packaging structures of the present invention;

11 Fig. 13 is a cross-sectional view of a conventional semiconductor
12 packaging structure; and

13 Fig. 14 is a cross-sectional view of another conventional semiconductor
14 packaging structure.

15 DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

16 With reference to Figs. 1 and 2, a first embodiment of a semiconductor
17 packaging structure comprises a lead frame (10) made of a metal material, a wall
18 portion (20), a chip (30) and a transparent cover (40).

19 The lead frame (10) has a die pad (11) for mounting the chip (30) and a
20 plurality of leads (12) arranged around the die pad (11), wherein each lead (12) is
21 separate from each other. Multiple gaps (14) each defined between two adjacent
22 leads (12), and an interval between the die pad (11) and the plurality of leads (12),
23 are all filled with an isolating resin (13) (as shown in Fig. 3).

24 The wall portion (20) is formed by molding compound and is installed at

1 periphery of the lead frame (10), wherein the wall portion (20) is also formed by an
2 isolating material. Both the wall portion (20) and the isolating resin (13) can be
3 formed integrally on the lead frame (10) by molding compound, or the wall portion
4 (20) is formed on the lead frame (10) after the isolating resin (13) is put in the gaps
5 (14). When forming the wall portion (20) on the lead frame (10), an outer flange of
6 the wall portion (20) can be formed in alignment with an outer flange of the lead
7 frame (10) (not shown in Figs.), or the outer flange of the wall portion (20) can be
8 formed behind the outer flange of the lead frame (10) (as shown in Fig. 3).

9 The chip (30) is mounted on the die pad (11) by a silver epoxy or other
10 kinds of solders and is further electrically connected to the plurality of leads (12)
11 via gold wires (31).

12 An enclosing means, such as the transparent cover (40), a pervious resin or
13 a metal cover, is applied on the packaging structure to enclose the chip (30) inside
14 the wall portion (20). In this embodiment, the transparent cover (40) is arranged on
15 the wall portion (20) to enclose the chip (30) inside the wall portion, so that the
16 transparent cover (40) is able to protect the chip (20) from the contaminant, such as
17 dust or moisture. Thereby, the packaging structure of the present invention is
18 complete.

19 Moreover, the transparent cover (40) is able to be replaced with a
20 transparent resin. Such a pervious resin is put inside the wall portion (20) to form a
21 complete packaging structure. Both the transparent cover (40) and the transparent
22 resin are suitable for the optical sensing semiconductor packaging structure. The
23 packaging structure of the present invention is also suitable for communication
24 semiconductor elements (such as a Surface Audio Wave Filter, SAW Filter), if the

1 transparent cover (40) is replaced with a metal cover. The metal cover can provide
2 a protection to the communication semiconductor element packaged inside, so that
3 the semiconductor element would not be affected by electromagnetic interference
4 (EMI).

5 With reference to Fig. 4, a second embodiment of the present invention is
6 shown. The second embodiment is substantially the same as the first embodiment
7 shown in Fig. 2. The only change is in the lead frame (10). The lead frame (10) of
8 the second embodiment further has multiple notches (15) which each is defined on
9 a bottom surface of the lead frame (10) and communicate with one of the multiple
10 gaps (14), wherein each notch (15) is formed by etching. An extending direction of
11 the notch (15) is toward to the outer flange of the lead frame (10) (as shown in Fig.
12 4), or the direction is bi-directional (the third embodiment), toward to the outer
13 flange of the lead frame (10) and the die pad (11) (as shown in Fig. 5).

14 With reference to Figs. 4 and 5, a thickness of a lateral side that defines the
15 notch (15) is smaller than a thickness of the lead frame (10), and the thickness of
16 the lateral side is only a half the thickness of the lead frame (10). Each notch (15) is
17 also filled with the isolating resin (13), wherein since the gap (14) is
18 communicated with the notch (15) and both are filled with the isolating resin (13),
19 the area that the isolating resin (13) contacts with the lead frame (10) is increased,
20 whereby the engagement force between the lead frame (10) and the isolating resin
21 (13) is enhanced.

22 With reference to Fig. 6, the fourth embodiment of the invention is shown.
23 The die pad (11) and the leads (12) in this embodiment are not in the same
24 horizontal plane. The die pad (11) is higher than the leads (12), whereby a space is

1 defined below the die pad (11) to receive the isolating resin (13). When the
2 isolating resin (13) is put in the space, the area that the isolating resin (13) contacts
3 with the lead frame (10) is greatly increased thereby the engagement force
4 between the lead frame (10) and the isolating resin (13) is also enhanced.

5 With reference to Figs 7 and 8, the fifth embodiment is shown. In this
6 embodiment, the lead frame (10) shown described foregoing is replaced with a
7 metal frame (10'), wherein the metal frame (10') is combined by an upper lead
8 frame (10a) and a lower lead frame (10b) through a thermal-compress process.
9 Before the thermal-compress process, the surfaces of the both the frames
10 (10a)(10b) can be electroplated with a metal film thereon to improve the
11 combination force.

12 With reference to Figs. 9 and 10, both the upper lead frame (10a) and the
13 lower lead frame (10b) have a die pad (11a)(11b) and a plurality of leads (12a)(12b)
14 arranged around the die pad (11a)(11b). A chip (30) is mounted on the die pad (11a)
15 of the upper lead frame (10a) and electrically connected to the plurality of leads
16 (12a) via gold wires (31).

17 The die pad (11a) of the upper lead frame (10a) is slightly bigger than that
18 of the lower lead frame (10b). The plurality of leads (12a) (12b) of the upper lead
19 frame (10a) and the lower lead frame (10b) have the different shapes, wherein each
20 of the plurality of leads (12a) of the upper lead frame (10a) has an external portion
21 extending toward the flange of the upper lead frame (10a) and an internal portion
22 extending toward the die pad (11a). However, each of the plurality of leads (12b)
23 of the lower lead frame (10b) only has an external portion corresponding to one of
24 the external portions of the leads (12a). An interval is defined between the die pad

1 (11a)(11b) and the plurality of leads (12a)(12b) for filling with the isolating resin
2 (13). Multiple gaps (14a)(14b) are each defined by two adjacent leads (12a)(12b),
3 wherein the multiple gaps (14a)(14b) are communicated with each other.

4 With reference to Fig. 11, when the upper lead frame (10a) and the lower
5 lead frame (10b) are in alignment with each other and compressed together to form
6 the metal frame (10'), and the leads (12b) of the lower lead frame (10b) are
7 corresponded to the leads (12a) of the upper lead frame (10a). Since the two die
8 pads (11a)(11b) and the leads (12a)(12b) of the upper lead frame (10a) and the
9 lower lead frame (10b) have the different size, once the two lead frames (10a)(10b)
10 are compressed together, multiple interstice (16) are defined for receiving the
11 isolating resin (13). The isolating resin (13) further fills the multiple interstice (16)
12 and the gaps (14a)(14b) by molding compound.

13 If the present invention is applied to a semiconductor packaging structure
14 that occupies a big volume, such as an optical element, the present invention can
15 be fabricated to form an independent packaging structure. Otherwise, with
16 reference to Fig. 12, if the present invention is applied to a packaging structure
17 with a small volume, such as a communication element, firstly the present
18 invention can be fabricated to form multiple packaging structures (a)
19 simultaneously, and then once the transparent covers (40) are fitted on the wall
20 portions (20), a cutter (b) is further used for isolating the multiple packaging
21 structures (a) to form an individual one, so that the production efficiency is able to
22 be increased.

23 From the foregoing description, the present invention has the following
24 advantages:

1 1. The present invention uses a lead frame to replace a substrate, the lead
2 frame can be formed by a stamping process or an etching process, whether the
3 stamping or the etching processes are very easy to manufacture and only incur a
4 low production cost.

5 2. Since the lead frame is made of metal, it would not absorb moisture and
6 thus the chip mounted on the lead frame would not be affected by the moisture and
7 has a good reliability.

8 3. Since the bottom of the die pad where the chip mounted thereon is
9 exposed to the air, the heat generating by the chip is directly conducted to the die
10 pad and then the heat is able to dissipate to the air through the die pad. Therefore
11 the present invention has a better heat dissipation efficiency than the conventional
12 epoxy resin substrate.

13 4. Since the chip is directly connected to the leads of the lead frame and the
14 leads are electrically and directly mounted on a circuit board, thus the signal
15 conduction path is very short and the conducting delay is avoid.

16 It is to be understood, however, that even though numerous characteristics
17 and advantages of the present invention have been set forth in the foregoing
18 description, together with details of the structure and function of the invention, the
19 disclosure is illustrative only, and changes may be made in detail, especially in
20 matters of shape, size, and arrangement of parts within the principles of the
21 invention to the full extent indicated by the broad general meaning of the terms in
22 which the appended claims are expressed.